Subsurface structures on rolled and re-crystallized W after D bombardment

re-crystallized W

Japanese ITER grade

additional re-crystallized

at 2073 K, 1h, H2-atmosphere

grain sizes ca 50 µm (lattice bcc)

SEM picture from re-cryst. initial sample: surface and cross-sectior

EBSD geometry

1 FRSD from sample surface

γ=50°

tilt 50

sample 20^o

max 25

20> <u>χ</u>=25° =180°

6

ര

12°

EBSD

25° to sample

S. Lindig^{a,*}, M. Balden^a, A. Manhard^a, C. Höschen^c, T. Höschen^a, B. Tyburska-Püschel^a, V.Kh. Alimov^b, J. Roth^a Max-Planck-Institut für Plasmaphysik, EURATOM Association, D-85748 Garching, Germany,

1. Motivation

Tungsten is a promising candidate as a plasma-facing material in the main chamber and also for divertor areas in fusion reactors. The erosion of this high-Z material by plasma is acceptably low and the D retention is intensively investigated by many international groups. The absolute D retention in W seems to be tolerable for the next generation of nuclear fusion devices like ITER or DEMO. But still clarification is needed how and under which conditions the D enters the material and where D is mainly accumulated.

Material

2. Experimental

Japanese ITER grade W

- rolled and swaged/forged W polycrystall; purity 99.99 %(wt) grain sizes elongated ca 1-5 µm (bcc, fiber texture [110])
- · deformation axis perpendicular to surface
- mechanically polished, cleaned in Acetone ultra-sonic bath • annealed 1473 K 30 min (stress relief)
 - W • pieces 10x10 mm², thickness ~2.5 mm • tvpical loaded with D-plasma 38 eV/D flux 10²² D/m²s, fluence 10²⁷ D/m² loading temperature range 300-700 K

2 EBSD fro

ഹ

SEM cross-section of initial Japanese ITER grade

Characterisation / equipment

- Helios Nanolab 600 (FEI): FEG-SEM with FIB at 52 Pt/C-deposition, stage: +60° -9° tilting
- EBSD camera (HKL/ Nordlys II Oxford) detector axis -12° under horizontal line
- EBSD-map (Oxford HKL Channel 5.0.9.1 Tango) • NanoSIMS 50L Cameca (TU-München^c) Cs+ , 16 keV; 10⁻¹⁰ mbar; pre-sputter 1x10²⁰ Cs/m²
- Tandem accelerator for NRA
- TDS (thermal desorption spectroscopy)

4. EBSD maps of plastic deformation

Fig a) shows re-crystallized W loaded with 5 · 10⁹⁶ D/m², 400 K, 10⁹² D/m²s, b) coated with protection Pt/C mixed layer for FIB-cutting, c) prepared for non-perpendicular cross-section-EBSD, d) tilt for EBSD-cut, EBSD steps (1-3) see also box 2 FIB-cutting, c) prepared for non e) cross-section for EBSD map



of one grain. Here the grain is bent up to 5° by plastic deformation during D loading. Without much doubt the very high transient super-saturation of D causes this strong deformation. Probably the cracks follow the cleavage planes in the grain.



EBSD map (Euler 2) in one grain. The deviation of the main orientation (46.2°) is colour-coded and selected line profiles show the misorientation relating to the first point.

6. Conclusion

- number and size of blister in mechanically polished polycrystalline W is nearly independent on temperature
- mechanically damaged surface layer promotes blistering

Stefan.Lindig@ipp.mpg.de

- · polycryst. W shows blisters at 700 K in contrast to re-crystallized W
- very high transient super-saturation during D exposure causes probably cracks and plastic deformations and plastic bending of grains of about 5° (up to 7°) over 1 µm length
- flux dependence of surface structures, cracks, deformations
- total D retention is in both types of materials is equal, measured by TDS
- D retention in near surface (until 7 µm) is in polycryst. W with damaged surface layer by mechanical polishing (technical surface?) until 5 times higher than in re-cryst. W
- hydrogen (H/D) can be localized with NanoSIMS on grain boundaries
- gas bursts during NanoSIMS-scans until now not clear explained (opened cavities ?)

3. Surface structures after D loading Variations of surface structures after loading temperatures from 300-700 K fluence 1027 D/m2; 1026 D/m2 flux 1022 D/m2s energy of D 38 eV re-crystallized W Japanese ITER grade W 320 K only rare structures and deformations D-content, measured by ion beam analyses NRA (nuclear reaction analyses) and TDS (thermal desorption spectroscopy) 320 K many surface structures, some marked by FIB cuts. Due to marking the blister collapsed. → blisters connected by a gas filled crack system es vary with vary with temperature: size and number of surface structures nearly independe on temperature no deformations, cracks (roly between grains) **300 K** only singular small bubbles appear with weak plastic deformations in the face subsurface 480 K many structures and strong deformations and cracks are visible (brittle) 600 K no cracks, deformations (only between gra no extrusion no extrusion all cavities are formed in the destroyed polished layer. inside the grain, **but extrusions** appear and a cavity is formed at the first grain boundary (ductile) **700 K** no structures are visible 480 K cracks, strong defor ations, many surf. structure ~ 700 K structures are visib flux dependence at re-crystallized W 5×4022 D 500 K / 600 K cross oss-sections show only cavities ed zone of surface as at 320 K. along the damaged zone or surrace as a The number and size of blisters are consu-Remark: Only very rare large grains show also extrusions from the grain boundary to surface as in re-crystalline samples D loading with different fluxes, low flux cause only large extrusion higher flux cause additionally small structures with cracks as abo 600 K large surface extrusions, cavities at the first grain boundary under the surface, no cracks, no bent grains EBSD measurement to clarify the formation mechanism blisters / cavities start always on probably weak boundaries between bulk and damaged surface By EBSD the grain orientation layer (by mechanical polishing). This damaged surface layer promotes obviously blister formation. could be determinate and the correlation between extrusion shape could be confirmed. The material is moved out along the gliding system {110}<111> (ductile). gliding system {110}<111> total D retention is equal in both types of materials. total D retention is equal in both types of materials, measured by TDS D retention in near surface (up to 7 μm) in polycryst. W with damaged surface layer by mechanical polishing (technical surface?) is up to 5 times higher than in re-cryst. W number and size of blister in mechanically polished polycryst. W are nearly independent on temperature polycryst. W shows blister also at 700 K mechanically damaged surface layer promotes bliste 705 K many surface structure visible, cross-sections also cavities 725 K no surface structures no features in cross-section

5. NanoSIMS, H localisation in re-cryst. W

First experiments were performed on a D loaded sample to investigate an expected accumulation of D at grain boundaries of re-crystallized W on the surface by Nano-SIMS (fluence 3×10¹⁹ Cs/m²). The first series shows a SE-picture made by Cs ions and maps in the light of mass numbers 16 (O),12 (C),1 (H) and 2 (H2 or D). At grain boundaries the H signal is significantly increased. It cannot be excluded that sample is saturated with H before D implantation.



The activities leading to these results has received funding from the European Atomic Energy Community's Seventh Framework Programme (FP7 / 2007-2011) under Grant Agreement 224752



Tritium Technology Group, Japan Atomic Energy Agency, Tokai, Ibaraki 319-1195, Japan ^c Lehrstuhl für Bodenkunde, TU-München, 85350 Freising-Weihenstephan, Germany